

All-Optical Noise Quenching of An Integrated Frequency Comb

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Integrated frequency combs promise transformation of lab-based metrology into disruptive real-world applications. These microcombs are, however, sensitive to stochastic thermal fluctuations of the integrated cavity refractive index, with its impact becoming more significant as the cavity size becomes smaller. This tradeoff between microcomb noise performance and footprint stands as a prominent obstacle to realizing applications beyond a controlled lab environment. Here, we demonstrate that small footprint and low noise become compatible through the all-optical Kerr-induced synchronization (KIS) method. Our study unveils that the phase-locking nature of the synchronization between the cavity soliton and the injected reference pump laser enables the microcomb to no longer be limited by internal noise sources. Instead, the microcomb noise is mostly limited by external sources, namely, the frequency noise of the two pumps that doubly pin the microcomb. First, we theoretically and experimentally show that the individual comb tooth linewidths of an octave-spanning microcomb remain within the same order-of-magnitude as the pump lasers, contrary to the single-pumped case that exhibits a more than two order-of-magnitude increase from the pump to the comb edge. Second, we theoretically show that intrinsic noise sources such as thermorefractive noise in KIS are quenched at the cavity decay rate, greatly decreasing its impact. Experimentally, we show that even with free-running lasers, the KIS microcomb can exhibit better repetition rate noise performance than the predicted thermorefractive noise limitation in absence of KIS.

Integrated frequency combs (microcombs) promise transformation of lab-based metrology into disruptive real-world applications. These microcombs are, however, sensitive to stochastic thermal fluctuations, with the impact on the frequency noise of both the individual comb teeth and the repetition rate becoming more significant with smaller cavity size.

Here, we demonstrate that small footprint and low noise become compatible through the all-optical Kerr-induced synchronization (KIS) method, where the phase-locking nature of the synchronization between the cavity soliton and a newly injected reference pump laser enables the microcomb to no longer be limited by internal noise. Instead, microcomb noise is mostly limited by external sources, namely, the frequency noise of the two pumps that doubly pin the microcomb.

We first show theoretically and experimentally that the individual comb tooth linewidths of an octave-spanning microcomb remain within the same order-of-magnitude as the pumps, contrary to the single-pumped case that exhibits a more than two order-of-magnitude increase from the pump to the comb edge. Second, we theoretically show that in KIS, intrinsic thermorefractive noise is quenched at the cavity decay rate, greatly decreasing its impact. Experimentally, we show that even with free-running lasers, the KIS microcomb can exhibit better repetition rate noise performance than the predicted thermorefractive noise limitation without KIS.

Optical frequency combs are essential components in

the metrological toolbox because they provide a coherent optical-to-microwave frequency link¹, enabling accurate optical frequency measurement²⁻⁵, which has found application in optical frequency synthesis⁶, spectroscopy⁷, microwave signal generation⁸, and ranging⁹, among others critical applications¹⁰⁻¹². To further lower the size, weight, and power consumption (SWaP) of combs for deployable applications, on-chip microcombs can be created by taking advantage of nonlinear photonic devices. Leveraging the third-order nonlinearity ($\chi^{(3)}$), integrated microring resonators can be designed to support dissipative Kerr soliton (DKS) states that exist by doubly balancing the loss/gain and dispersion/nonlinear phase shift of the system^{13,14}, which once periodically extracted create a uniformly spaced pulsed train, and hence an on-chip frequency comb. While many applications of table-top frequency combs have been reproduced at the chip-scale thanks to DKSs¹⁵⁻²⁰, these integrated microcombs fall short in their repetition rate noise performance - primarily due to their poor ability to manage the cavity thermorefractive noise (TRN)²¹⁻²⁴, which increases inversely with the resonator size²⁵. Since TRN locally modifies the material refractive index, the cavity soliton experiences transduction of this noise onto both its group and phase velocity, which respectively impact the repetition rate and the carrier envelope offset (CEO) of the microcomb [Fig. 1A]. This noise transduction is particularly consequential for octave-spanning microcombs, where CEO detection and stabilization is a focus, and where SWaP considerations favor a high repetition rate to maximize individual comb tooth power within an octave, resulting in the use of a small microring resonator^{20,26-28}. Mitigation of TRN is possible, for instance through judicious use of a cooler-laser that can squeeze

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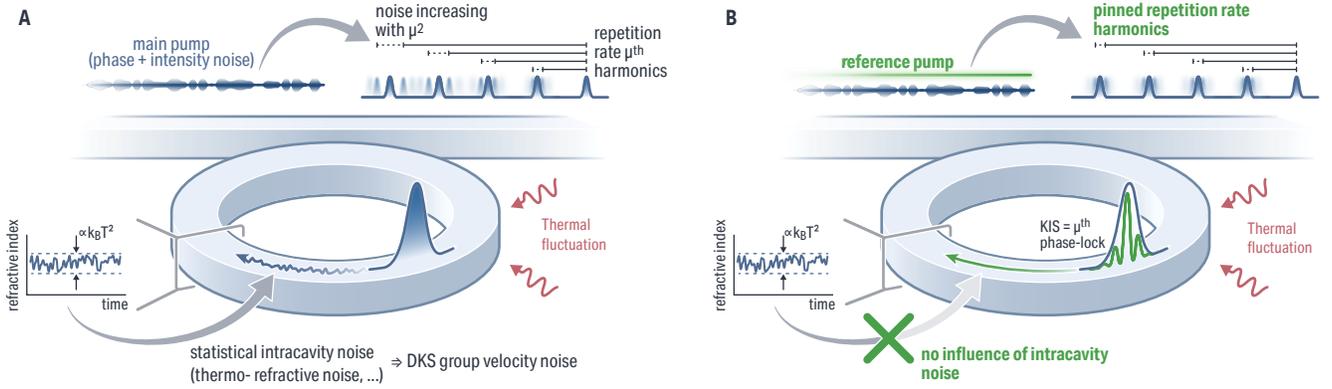


Fig. 1 – DKS thermo-refractive noise and its circumvention through Kerr-induced synchronization (KIS). (A) Single pump scenario. The statistical fluctuation of the cavity temperature modifies the cavity material refractive index, which in turn impacts the group velocity of the cavity soliton and hence the repetition rate of the generated frequency comb. In addition, the frequency noise of the pump is transduced onto the cavity soliton group velocity, resulting in noise that increases quadratically between one pulse and another separated by harmonics of the repetition period. In the frequency domain, this corresponds to increasing noise as a function of comb tooth mode number μ with respect to the pump. (B) In Kerr-induced synchronization, a reference is sent to the microcavity where the DKS lives, resulting in a phase locking of the cavity soliton to the reference phase velocity. Since the soliton repetition rate is now determined by external parameters that are the two pump frequencies, intrinsic noise sources such as TRN are bypassed and no longer affect the DKS repetition rate. In addition, the microcomb is now dual-pinned at the comb tooth closest to the reference and at the main pump, resulting in noise propagation onto the comb teeth that is damped relative to the single pump case.

the resonator temperature fluctuations under low cooler power²⁹, leading to an improvement in the repetition rate noise by about an order of magnitude²¹. Other promising methods such as dispersion engineering to tailor the recoil and counterbalance TRN have been proposed³⁰, and could potentially fully quench it. Yet, such engineering is challenging for octave-spanning combs since the dispersion would need to simultaneously support the desired microcomb bandwidth and the required asymmetry for TRN suppression. A final solution is to strongly suppress TRN by working at cryogenic temperature, which reduces the thermorefractive coefficient by more than two orders of magnitude³¹, and has been demonstrated to enable direct and adiabatic DKS generation³². Though very effective at removing TRN and other vibrational-based noise sources (*e.g.*, Raman scattering), the significant infrastructure requirements are incompatible fieldable applications. Beyond repetition rate noise, the individual comb tooth linewidths, which are directly related to the noise of the pump laser through a so-called elastic-taped model³³, can also be a limitation. Here, the frequency noise power spectral density (PSD) of the pump laser propagates quadratically with the comb tooth mode number – which in the temporal domain corresponds to a quadratic increase of noise between pulses separated by harmonics of the repetition period [Fig. 1A] – and broadens the comb teeth beyond the linewidth of the pump laser. For octave-spanning combs, where comb teeth that are hundreds of modes away from the pump are used (*e.g.*, in self-referencing), this can be a significant limitation.

Recently, a new method to stabilize the DKS has been proposed, called Kerr-induced synchronization (KIS)²⁸. KIS relies on the phase locking of the intra-cavity soliton to an external reference laser injected in the same resonator where the soliton circulates, which locks their

respective CEOs [Fig. 1B]. This method has been demonstrated to be highly versatile as any comb line can be synchronized³⁴, and multi-color synchronization that stabilizes the common repetition rate can also be achieved³⁵. It allows for a passive and all-optical stabilization of the microcomb to an optical frequency reference, providing long-term stability for clockwork applications²⁸ with optical frequency division of the pumps' noise onto the repetition rate^{34–36}. Here, we theoretically analyze and experimentally demonstrate the profound improvements that KIS enables on the repetition rate noise and individual comb tooth noise in DKS microcombs. We show that the addition of a second intracavity field through the reference critically modifies the elastic-tape model describing the increase of the comb tooth linewidth away from the main pump such that under KIS, all comb tooth linewidths remain within the same order of magnitude, across a span of more than 200 comb lines. In addition, we demonstrate theoretically and experimentally that synchronization through the reference laser renders the cavity soliton insensitive to internal cavity noise, in particular TRN, thereby essentially bypassing current limitations on microcomb noise performance [Fig. 1B] and enabling any cavity size to perform at the same noise level as a large resonator. We experimentally verify our numerical and theoretical analyses using an octave-spanning integrated microcomb with a volume of $\approx 80 \mu\text{m}^3$, for which we obtain lower repetition rate noise than the TRN-limited value while using free-running pumps.

Individual comb tooth linewidth reduction in KIS — First, we will discuss the optical linewidth of the individual teeth forming the comb, which is critical in applications such as optical frequency synthesis and spectroscopy, where having narrow individual comb teeth is essential. As discussed previously, we will focus on free-

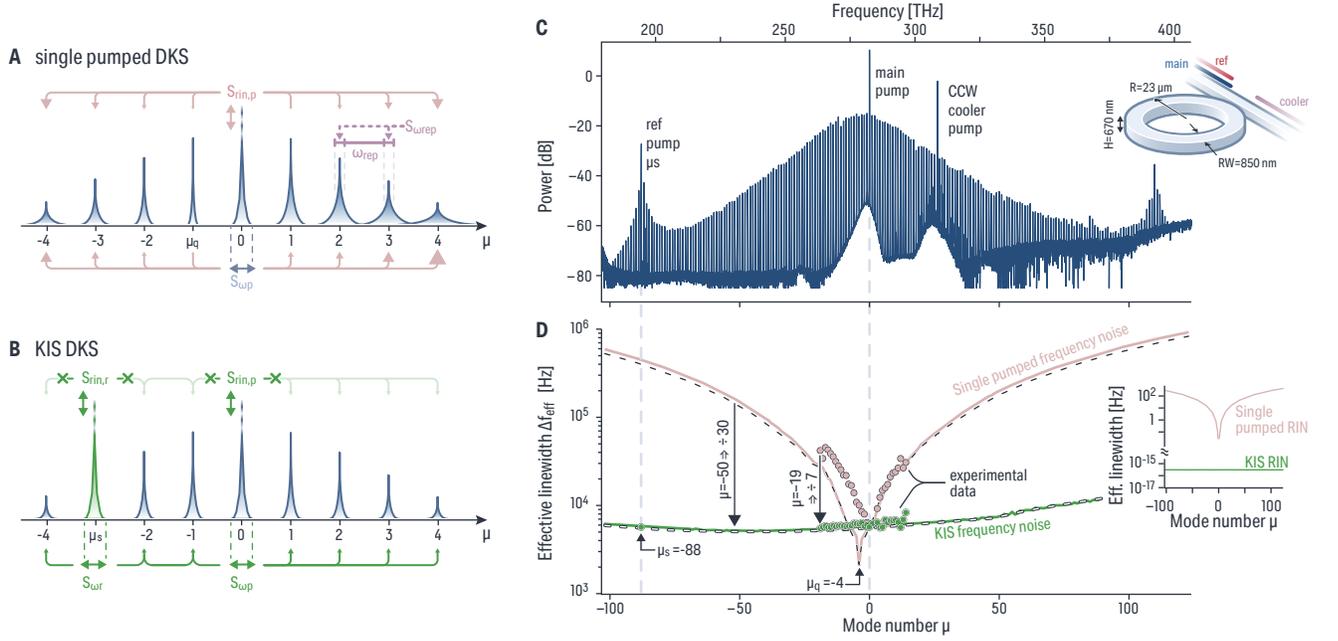


Fig. 2 – Impact of KIS on the individual comb teeth linewidths – (A) Schematic of noise propagation of the single-pumped microcomb following the elastic-tape model. The frequency noise of the pump $S_{\omega,p}$ cascades with a μ^2 scaling relative to a quiet point μ_q that is defined by intrinsic properties of the microring material and dispersion. In addition, the relative-intensity noise of the pump $S_{\omega,rin}$ also propagates onto the frequency noise of the comb with a quadratic scaling μ^2 . (B) In KIS, dual-pinning of the comb through the introduction of the reference now prevents any RIN transduction onto the comb teeth frequency noise. While the elastic-tape model for noise propagation still exhibits a quadratic trend μ^2 , the dual-pinning greatly limits the propagation of each pumps’ noise, $S_{\omega,p}$ and $S_{\omega,r}$, onto the comb teeth. (C) Optical spectrum of the experimental microcomb obtained with a main pump at $\omega_{pmp}/2\pi \approx 282.4$ THz (1061 nm) and the reference at $\omega_{ref}/2\pi \approx 194.5$ THz (1540.1 nm), from a Si_3N_4 microring resonator with dimensions $R = 23\ \mu\text{m}$, $RW = 850\ \text{nm}$, and $H = 670\ \text{nm}$ (inset). We use a cooler pump at $\omega_{cool}/2\pi \approx 308.7$ THz (971.8 nm) for DKS access. (D) Effective linewidths of the individual comb teeth from analytical prediction (dashed lines), LLE simulation (solid lines), and experimental data (circles) with free running laser pump(s). In the single-pump case, the pump frequency noise propagates quadratically with the comb tooth mode number μ , exhibiting a quiet point at $\mu = -4$. In contrast, in KIS noise propagation is damped, as the comb tooth frequency noise must match that of each pump at $\mu = 0$ and $\mu_s = -87$, due to the double pinning of the comb by the two lasers. The experimental data matches well with the KIS model, while a discrepancy is observed for the single pump that is mostly related to thermo-refractive noise that is not yet included in the model. The inset shows the LLE simulation with the pump(s) relative intensity noise (RIN), which impacts the comb teeth linewidths in the single pump case (pink), while is totally suppressed in the KIS case (green). Propagation of RIN is suppressed in KIS since the soliton group velocity is insensitive to pump power fluctuations as the repetition rate is pinned by the frequencies of the two pumps.

running operation, where two main noise sources from the DKS pump laser can be considered: frequency noise and residual intensity noise (RIN); laser shot noise will be neglected since the frequency noise will be orders of magnitude larger when not locked to a stable reference cavity. Other intrinsic noise of the microring resonator, such as TRN, will be discussed later in the paper.

In the single-pumped DKS, noise propagation from the pump, either from its frequency noise or RIN, to the microcomb teeth follows the well-known elastic-tape model³³. Interestingly, the frequency noise must account for soliton-recoil²³, which can appear from the Raman self-frequency shift^{37,38} (neglected here since its impact is marginal in Si_3N_4 compared to other materials³⁹), and/or dispersive wave-induced rebalancing where the center of mass of the DKS must be null⁴⁰. The PSD of a comb tooth μ , referenced to the main pump ($\mu = 0$), can be written as $S^{1p}(\mu, f) = S_{\omega,rin}^{1p}(\mu, f) + S_{\omega,p}^{1p}(\mu, f)$, with $S_{\omega,rin}^{1p}(\mu, f) = S_{\omega,rin,p}(f)\mu^2$, where $S_{\omega,rin,p}$ already accounts for the power-to-frequency noise transduction from the pump and the frequency noise PSD defined as

described in ref 23 as:

$$S_{\omega}^{1p}(\mu, f) = S_{\omega,p}(f) \left(1 - \frac{\partial\omega_{rep}}{\partial\omega_p}\mu\right)^2 \quad (1)$$

Here, $S_{\omega,p}$ is the frequency noise PSD of the main pump, ω_{rep} is the repetition rate, and ω_p is the main pump frequency. Therefore, the main pump noise cascades onto the comb teeth at a quadratic rate [Fig. 2A]. The superscript $1p$ refers to the single-pump DKS operation, which will be compared against the KIS regime. It thus becomes obvious that, apart from a quiet comb tooth at $\mu_q = (\partial\omega_{rep}/\partial\omega_p)^{-1}$, the noise propagation makes the individual comb teeth broader than the pump itself, in particular for teeth far from the pump. As such comb teeth are of critical importance in octave-spanning combs, this noise propagation is a hindrance on performance.

Since KIS involves phase locking of the frequency components at the reference mode μ_s , resulting in the capture of the comb tooth closest to the reference pump laser, the noise propagation from the pump lasers will be largely different from the single pump regime [Fig. 2B]. First,

the microcomb is now fully defined by the frequency of both lasers, regardless of their power. Thus, as long as the cavity soliton remains within the KIS bandwidth, which is dependent on the DKS μ_s modal component and reference intracavity energies^{28,41} and is ≈ 1 GHz here, the impact of RIN from both pumps on the individual comb teeth will be entirely suppressed, such that $S_{\omega_{\text{rin}}}^{kis}(\mu) = 0$ [Fig. 2D-inset], where the *kis* superscript refers to the KIS regime throughout the manuscript. Hence, in our approximation to dismiss for the moment the microring intrinsic noise, the only contribution to the individual comb tooth noise PSD $S_{\omega}^{kis}(\mu)$ comes from the frequency noise cascading of both pumps. Since the captured comb tooth and the reference pump became indistinguishable in KIS, the comb tooth frequency noise is now pinned at each of the two pumps. In addition, the repetition rate noise must be the same for any two adjacent comb teeth considered. Hence, the noise propagation must also follow an elastic-tape model, this time adjusted for the dual-pinning such that:

$$S_{\omega}^{kis}(\mu, f) = S_{\omega,p}(f) \left(1 - \frac{\mu}{\mu_s}\right)^2 + S_{\omega,r}(f) \left(-\frac{\mu}{\mu_s}\right)^2 \quad (2)$$

with $S_{\omega,r}$ the frequency noise PSD of the reference pump and μ_s the comb tooth order undergoing KIS. It is interesting to compare the frequency noise in both regimes. Assuming the same frequency noise for both pump lasers $S_{\omega,p} = S_{\omega,r}$, and that $S_{\omega_{\text{rin}}}(\mu) \ll S_{\omega}(\mu)$, which is obviously true in the KIS case and has been demonstrated in the single pump regime²³, one will observe $S_{\omega}^{1p} < S_{\omega}^{kis}$ for the modes $\mu = [2\mu_s\mu_q(\mu_s - \mu_q)/\mu_s^2 - 2\mu_q^2; 0]$. One of the main advantage of KIS is the possibility to dual-pin the microcomb's widely-separated modes^{28,34}, while the recoil responsible for μ_q is usually close to the main pump. Hence, assuming $\mu_s \gg \mu_q$, the single pump comb teeth PSD will only be better than the KIS one for a range $\mu = [2\mu_q; 0]$, which by definition is narrow since μ_q is small. In contrast, the KIS microcomb will exhibit better single comb line frequency noise PSD performance across a broadband spectrum.

To demonstrate such performance improvement through KIS, we use an integrated microring resonator made of $H = 670$ nm thick Si_3N_4 embedded in SiO_2 , with a ring radius of $R = 23$ μm and a ring width of $RW = 850$ nm. This design provides anomalous dispersion around 283 THz (1060 nm) with higher-order dispersion providing nearly harmonic dispersive waves (DWs) at 194 THz and 388 THz, corresponding to $\mu = -88$ and $\mu = 110$ respectively [Fig. 2C]. We measure the individual comb lines from $\mu = -19$ to $\mu = 14$ using a high-rejection and narrowband optical filter and an optical frequency discriminator (see Supplementary Information S.6 for details), while both main and reference pumps remain free running with an effective linewidth $\Delta f_{\text{eff}} \approx 5.8$ kHz determined from the laser PSD measurement following the definition⁴² $\int_{\Delta f_{\text{eff}}}^{+\infty} S_{\omega}(f)/f^2 df = 1/\pi$. In the KIS regime, the measured comb teeth effective linewidths remain in the 5 kHz to 7 kHz range, obtained from their frequency

noise spectra in a similar fashion as the pumps. The experimental data closely matches Lugiato-Lefever equation (LLE) simulations accounting for both pumps⁴³, which in addition matches the dual-pinned elastic-taped model introduced above. Here, the experimentally measured frequency noise PSD for each pump is input into the LLE simulation. Such close agreement between the model and the experimental data enables us to predict a comb tooth linewidth that will not exceed $\Delta f_{\text{eff}} = 15$ kHz for modes as far as $\mu = +120$. In sharp opposition, the predicted noise of the single pump case, which as expected from previous work^{23,33} matches between the LLE and analytical model assuming a quiet comb line at $\mu_p = -4$ obtained from the maximum of the sech^2 envelope of the experimental microcomb, yields an effective linewidth above 50 kHz (10 \times that of the main pump) for modes below $\mu = -28$ or above $\mu = 22$, and as high as 500 kHz for modes close to the DWs. Experimentally, we confirmed such a trend, where Δf_{eff} increases with separation from the main pump, with $\Delta f_{\text{eff}} \approx 40$ kHz for $\mu = -19$. However, we do not observe a quiet mode in the measurements, and instead all comb lines exhibit higher noise than the pump. This discrepancy, which has been observed previously²³, is mostly related to TRN that is not yet accounted for in the model. The lack of impact of its absence in modeling the KIS results already hints at its quenching in that regime, while it is the predominant noise source in the single pump case. Additionally, LLE simulations confirm the intuition that pump RIN has been entirely removed from influencing the effective linewidths of the comb teeth in the KIS regime [Fig. 2D inset], while it is a non-negligible contribution in the single pump case.

Theoretical study of intrinsic noise suppression in Kerr-induced synchronization — Since we observed good agreement between KIS experimental data and the theoretical dual-pinned elastic tape model that only accounts for pump frequency noise, while the single pump case presents a discrepancy which can likely be attributed to TRN, we now focus on studying the microring resonator's intrinsic noise and how KIS modifies its impact on the cavity soliton. With this in mind, we study noise of the repetition rate ω_{rep} of the comb rather than noise of individual comb lines, since we have shown that regardless of operating in KIS or the single pump regime, noise propagates through an elastic-tape model. We proceed with a linear stability analysis of the LLE for the cavity soliton outside of synchronization (*i.e.*, akin to single pump operation) and in the KIS regime.

Our starting point is the multi-driven LLE (MLLE)^{43,44}, normalized to losses (see Supplementary Information S.2 for details), which can be written as:

$$\begin{aligned} \frac{\partial \psi}{\partial t} = & -(1 + i\alpha_p)\psi + i \sum_{\mu} \mathcal{D}(\mu) \tilde{\Psi} e^{i\mu\theta} + i|\psi|^2\psi \quad (3) \\ & + F_p + F_{\text{ref}} \exp\left[i\left(\alpha_{\text{ref}} - \alpha_p + \mathcal{D}(\mu_s)\right)t - i\mu_s\theta\right] \end{aligned}$$

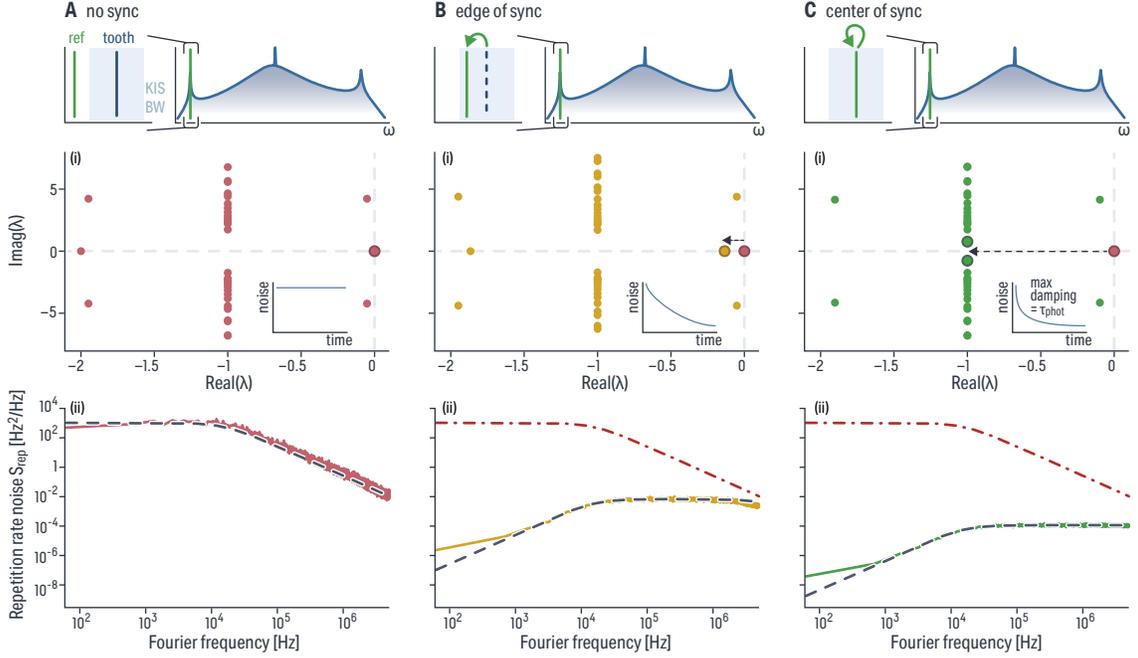


Fig. 3 – Theoretical study of intrinsic noise suppression in KIS – (A) (i) Linear analysis complex eigenvalue representation in the unsynchronized case. The highlighted eigenvalue (large red circle) is the position-shifting eigenvalue λ_{ps} , which in this case is null and corresponds to perturbations, like thermo-refractive noise (TRN) fluctuation of the DKS group velocity, persisting (inset). (ii) The Lugiato-Lefever simulation accounting for stochastic TRN (solid curve) is in good agreement with the analytical model (dashed black line). (B) (i) Similar study with the reference at the edge of the KIS bandwidth. The position-shifting eigenvalue has shifted, presenting a negative real value, and hence fluctuations are damped at a rate $\lambda_{ps}\kappa$, with κ the photon loss rate. (ii) This results in the power spectral density of the repetition rate noise S_{rep} whose spectral profile changes (solid line) and is reduced in accordance with the analytical analysis Eq. (13) (dashed black line). The unsynchronized case (dot-dashed red line) is also displayed for comparison. (C) Similar study as in (A) and (B), with the reference at the center of the KIS BW, that is, in the original location of the soliton comb tooth. (i) $\lambda_{ps} = -1$, reaching its minimum value and maximum damping. Numerically, the phase-perturbation eigenvalue — which is present in the unsynchronized case at -2, and shifted symmetrically with λ_{ps} in the edge-of-synchronization case — becomes indistinguishable from λ_{ps} . They thus hybridize, resulting in a symmetric splitting of their imaginary value around 0. (ii) S_{rep} is minimized since the damping rate has been maximized (and given by κ).

where ψ is the normalized intracavity field of the DKS following ref. 43 and detailed in Supplementary Information S.2, θ is the azimuthal coordinate of the ring, μ is the azimuthal mode number, Ψ is the Fourier transform of ψ from θ to the μ domain, t is the normalized time, $\alpha_p(\alpha_{\text{ref}})$ is the normalized detuning of the primary (reference) pump, F_p (F_{ref}) is the intra-cavity power of the primary (reference) pump, $\mathcal{D}(\mu)$ is the normalized integrated dispersion of the cavity as a function of relative mode number μ , and μ_s is the mode number of the reference pump in KIS.

In general, Eq. (3) admits multi-color soliton solutions. In the KIS regime, the soliton solution does not change except for a constant drift which is associated with the time-dependence of the reference pump field. Additionally, the reference pump field and the DKS field are stationary with respect to each other in the KIS regime. We can change the frame of reference in Eq. (3) to obtain an equation with stationary solutions:

$$\theta - \frac{(\alpha_{\text{ref}} - \alpha_p + \mathcal{D}(\mu_s))}{\mu_s} t = \theta', \quad t = t'. \quad (4)$$

This frame of reference rotates with an angular velocity where the reference pump is stationary. Using

$$\frac{\partial}{\partial \theta} = \frac{\partial}{\partial \theta'}, \quad (5)$$

$$\frac{\partial}{\partial t} = -\frac{(\alpha_{\text{ref}} - \alpha_p + \mathcal{D}(\mu_s))}{\mu_s} \frac{\partial}{\partial \theta'} + \frac{\partial}{\partial t'}, \quad (6)$$

we can rewrite Eq. (3) as:

$$\begin{aligned} \frac{\partial \psi}{\partial t} = & -(1 + i\alpha_p)\psi + i\Sigma_\mu \mathcal{D}(\mu)\Psi e^{i\mu\theta} \\ & + \frac{(\alpha_{\text{ref}} - \alpha_p + \mathcal{D}(\mu_s))}{\mu_s} \frac{\partial \psi}{\partial \theta} + i|\psi|^2\psi \\ & + F_p + F_{\text{ref}} \exp[-i\mu_s\theta]. \end{aligned} \quad (7)$$

For convenience, we have dropped the primes in Eq. (7). The MLLE in the form of Eq. (7) admits stationary solutions in the KIS regime as the right-hand side is time-independent. Now, the stability of the soliton in the presence of perturbations can be studied using dynamical techniques. For the given set of parameters, we can calculate the stationary solution ψ_0 using the Levenberg-Marquardt algorithm such that $\frac{\partial \psi_0}{\partial t} = 0$. Following the procedure described in Ref 45, we linearize Eq. (7) around

ψ_0 to obtain:

$$\frac{\partial \Delta\psi}{\partial t} = \mathcal{L}(\psi_0)\Delta\psi, \quad (8)$$

where $\Delta\psi$ is a perturbation and $\mathcal{L}(\psi_0)$ is the linearized operator. Solving Eq. (8), we obtain the effect of the system on the perturbation after time Δt :

$$\Delta\psi(t_0 + \Delta t) = \exp[\mathcal{L}(\psi_0)\Delta t] \Delta\psi(t_0). \quad (9)$$

In general, one can decompose any perturbation into a linear combination of eigenfunctions v_n of $\mathcal{L}(\psi_0)$, with corresponding eigenvalues λ_n . Therefore,

$$\begin{aligned} \Delta\psi(t_0) &= \sum_n a_n v_n, \\ \Delta\psi(t_0 + \Delta t) &= \sum_n \exp[\lambda_n \Delta t] a_n v_n. \end{aligned} \quad (10)$$

From Eq. (10), it is clear that a perturbation to the DKS grows exponentially if $\text{Re}(\lambda_n) > 0$, persists if $\text{Re}(\lambda_n) = 0$, and damps exponentially if $\text{Re}(\lambda_n) < 0$. In all cases, there is one eigenvalue λ_{ps} , referred to as the position-shifting eigenvalue, whose eigenfunction corresponds to perturbations of the DKS position inside the cavity. Perturbations of the form of the position-shifting eigenfunction are responsible for fluctuations in the repetition rate of the soliton. For the singly-pumped DKS [Fig. 3A(i)], $\lambda_{ps} = 0$, which implies that perturbations to the soliton position due to noise persist. However, in the KIS regime, the soliton is trapped by the two pumps, and results in $\lambda_{ps} < 0$ [Fig. 3B(i)], which implies that perturbations to the DKS damp exponentially. When the reference pump's detuning is at the center of the synchronization window, $\lambda_{ps} = -1$ [Fig. 3C(i)]. This is the most negative value that λ_{ps} can take, and therefore sets the fundamental limit for damping of the repetition rate noise, which after accounting for the normalization with respect to the total loss κ , corresponds to exponential damping of the intra-cavity noise by the photon lifetime $\tau_{\text{phot}} = 1/\kappa$.

To verify the stability analysis conducted, we performed stochastic LLE simulations accounting for intra-cavity TRN, for which the repetition rate can be extracted at every-round trip time and processed to obtain its PSD. These simulations account for the impact of TRN on pump detunings $\alpha_{p,r}$ and the dispersion $\mathcal{D}^{21,30}$, and using either simulated or experimentally determined values for other parameters (see Supplementary Information S.1). In the unsynchronized case [Fig. 3A(ii)], the simulated repetition rate noise matches well with the analytical one that can be obtained following ref.³⁰:

$$S_{\text{rep}}^{1p}(f) = \frac{\eta_T^2 k_B T^2}{\pi \rho C V} \frac{\Gamma_T}{(f^2 + \Gamma_T^2)} \quad (11)$$

with $\eta_T = \partial\omega_{\text{rep}}/\partial T|_{T_0}$ calculated when not synchronized (details in Supplementary Information S.3), ρ the material density, C its specific heat, and V the modal volume of the fundamental transverse electric mode, Γ_T the thermal

dissipation rate, T the temperature, k_B the Boltzmann constant, and f the Fourier frequency. Details for the parameter values and the methods by which they were obtained can be found in Supplementary Information S.4. Consistent with the linear stability analysis, the ω_{rep} PSD result from the stochastic LLE exhibits a much lower noise level in the KIS regime [Fig. 3B(ii)], which is minimized when the reference is at the center of the KIS bandwidth (*i.e.*, where the comb tooth is originally) [Fig. 3C(ii)]. In our simulation, the frequency noise of the pumps has been neglected, yielding driving fields that are perfect Dirac delta functions spectrally and hence resulting in the reduction of the PSD at low Fourier frequencies. Interestingly, one could derive an analytical expression for the repetition rate noise in the KIS regime, which can be obtained from the linear stability analysis of the MLE regime:

$$\frac{\partial \Delta\omega_{\text{rep}}}{\partial t} = \kappa \lambda_{ps} \Delta\omega_{\text{rep}} + \eta_T \frac{\partial \Delta T}{\partial t} \quad (12)$$

with κ the total loss rate of the cavity, λ_{ps} the position-shifting eigenvalue, and $\Delta\omega_{\text{rep}}$ the repetition rate noise. The PSD of the repetition rate noise can then be derived following Supplementary Information S.1 such that:

$$S_{\text{rep}}^{kis}(f) = S_{\text{rep}}^{1p}(f) \times \frac{f^2}{f^2 + \lambda_{ps}^2 \kappa^2} \quad (13)$$

Outside of synchronization $\lambda_{ps} = 0$ yields the same expression as the single pump case (Eq. (11)) with a typical Lorentzian profile in the Fourier frequency space. In the KIS regime, the noise spectrum is then damped by the $f^2/(f^2 + \lambda_{ps}^2 \kappa^2)$ term, which is in good agreement with the simulations [Fig. 3A(ii)-C(ii)], albeit with a discrepancy at low Fourier frequency due to the finite simulation finite time and averaging. In comparison to the conventional single pump DKS, the PSD profile of $\Delta\omega_{\text{rep}}$ is dramatically altered, since at low frequency it follows a $S f^2/\Gamma_T \lambda_{ps}^2 \kappa^2$ profile, with $S = \frac{1}{\pi} \frac{\partial\omega_{\text{rep}}}{\partial T} \frac{k_B T^2}{\rho C V}$. As the thermal dissipation rate is much slower than the photon decay rate ($\Gamma_T \ll \kappa$) in the microring, this hints at the good long term stability of the repetition rate, which will no longer be hindered by incoherent intracavity noise processes such as TRN, in contrast to the single pump case that exhibits a typical plateau at S/Γ_T at low Fourier frequencies. At high Fourier frequency $f > \lambda^2 \kappa^2$, the PSD in KIS will follow the Lorentzian profile imposed by the thermal noise, yet the Fourier frequency at which it happens is λ_{ps} dependent since a plateau at $S\Gamma_T/\lambda_{ps}^2 \kappa^2$ will be observed for $f \in [\Gamma_T; \lambda^2 \kappa^2]$; however, this plateau occurs at a value that is still much lower than the noise in the single pump case, which follows a $1/f^2$ trend. Such dependence of the repetition rate noise PSD on λ_{ps} is a direct consequence of the timescale at which the synchronization of the cavity soliton with the reference occurs. At the edge of the KIS bandwidth, the synchronization is slower since the soliton must adapt its repetition rate within the nonlinear Kerr effect timescale. This results in a small λ_{ps} and hence

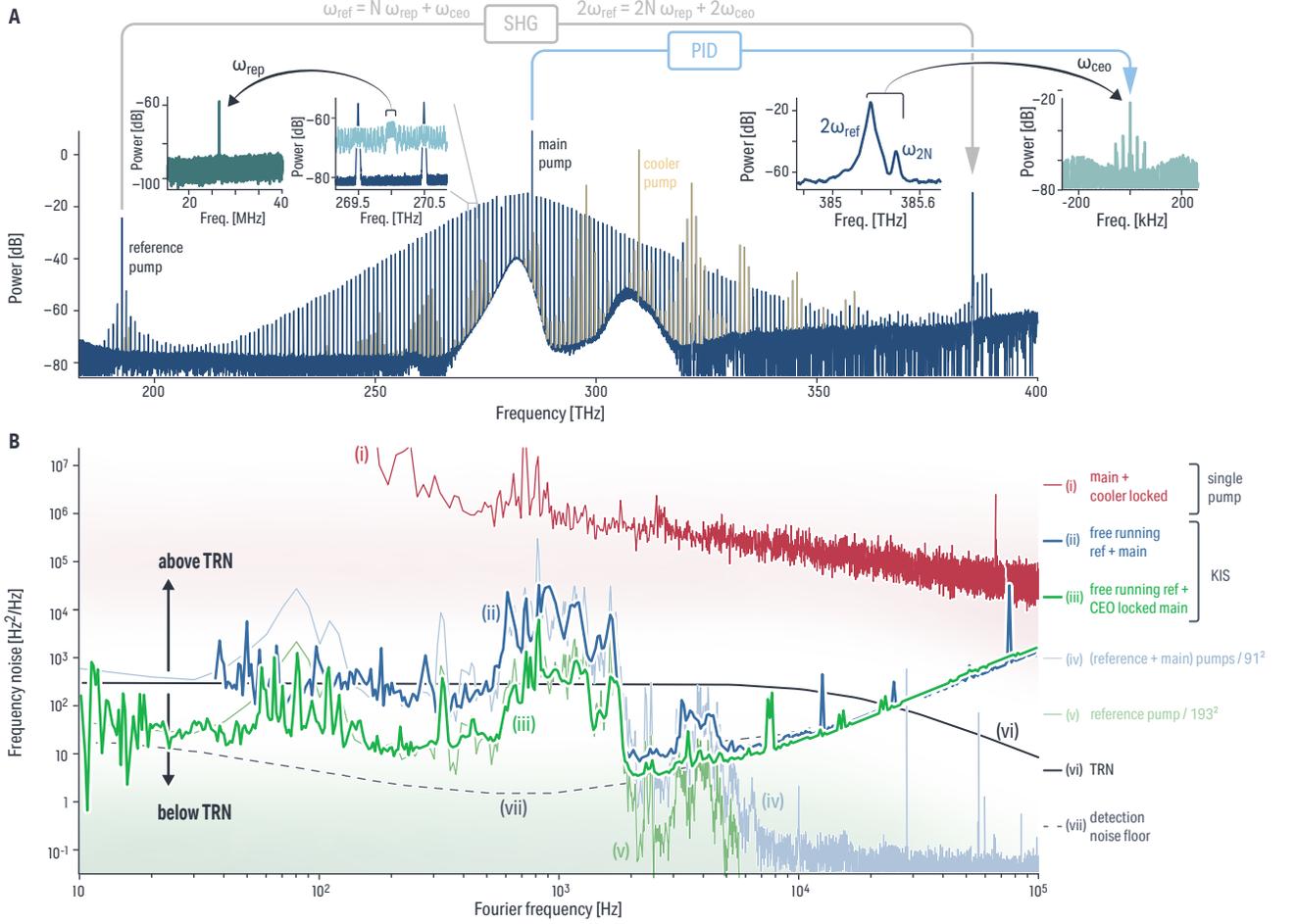


Fig. 4 – Experimental demonstration of thermo-refractive noise quenching with KIS – (A) Experimental spectrum of the octave-spanning microcomb pumped at $\omega_{\text{rep}} \approx 285.5$ THz with the reference pump at $\omega_{\text{rep}} \approx 192.6$ THz. A strong cooler pump is used to thermally stabilize the temperature of the resonator which, while being cross-polarized and sent in opposite direction to the main pump, results in some nonlinear interaction (yellow spectrum). The frequency doubled reference is obtained through a second-harmonic generation (SHG) nonlinear crystal and beat against the closet comb tooth at $2f$. We measure the beat note using an electro-optic comb and lock the carrier-envelope offset frequency (CEO) to a 10 MHz Rb frequency standard through feedback to the main pump frequency. The repetition rate is measured around 270 THz with an electro-optic comb that spectrally translates two adjacent microcomb teeth through higher-order sidebands, enabling detection within a 50 MHz bandwidth. **(B)** Frequency noise obtained for a single pumped microcomb with frequency-locked cooler (i, red), KIS microcomb with free-running main and reference pumps (ii, dark blue) and KIS microcomb with free-running reference pump and locked CEO through feedback to the main pump (iii, green). The frequency noise of the pumps, which is similar for both reference and main pump, is overlaid in thin lines for each KIS case after accounting for the relevant optical frequency division (OFD) factor. When both pumps are free-running, the $OFD = 91^2$ corresponds to the comb tooth separation between the pumps (v), and accountin for both pumps not sharing any common noise, is in good agreement with the detected repetition rate noise. In the CEO-locked case, $OFD = 193^2$ (vi), which further reduces the repetition rate noise (here the noise on the CEO lock can be neglected and only the free-running reference pump noise is a factor). In both KIS cases, the single-pumped (without cooler) TRN limit (vi, black solid line) is beaten. The detection noise floor (vii, dashed line) is limited by the RF synthesizer used in the electro-optic comb repetition rate measurement apparatus.

$S_{\text{rep}}^{\text{kis}}$ catches up with $S_{\text{rep}}^{\text{1p}}$ at relatively low frequencies. In contrast, at the center of the KIS bandwidth, synchronization is faster since the reference pump is already at the frequency for which the soliton exists in the single pump case. This results in a larger λ_{ps} and a higher frequency at which $S_{\text{rep}}^{\text{kis}}$ catches up with $S_{\text{rep}}^{\text{1p}}$. However, the overall limitation remains the photon lifetime $1/\kappa$, since it limits both the loading time for which the reference can be injected in the microring resonator and the photon dissipation of the previously unsynchronized cavity soliton. The above results are similar to the so-called “quantum diffusion

limited” counter-propagative solitons⁴⁶. Here, the theoretical timing jitter limitation of solitons are obtained through a Lagrangian approach⁴⁷, where an equivalent to KIS occurs between solitons in each direction⁴⁸, since both systems obey an analogous Alder equation. This analysis yields a noise limited by the photon lifetime $1/\kappa$. Importantly, here we expand such a quantum diffusion limit to a single soliton, where the synchronization is enabled through entirely controllable external parameters provided by the two laser pumps, instead of using synchronization between two soliton states. We note that while

ultra-high Q provides net benefits in terms of reducing the pump power needed to generate Kerr solitons, when it comes to minimizing the impact of intrinsic noise, it is advantageous to reduce Q to have a photon lifetime $1/\kappa$ as short as possible. In this context, Si_3N_4 microring resonators present a critical advantage under KIS compared to much larger volume crystalline resonators with ultra-high- Q (e.g., 10^9)⁴⁹, since our microring exhibits a decrease in the photon lifetime by about three orders of magnitude while retaining a small enough modal volume to enable relatively low pump power DKS existence, and no longer suffers TRN-related limitations thanks to KIS.

Experimentally reaching and beating thermo-refractive noise — Finally, we experimentally demonstrate that KIS quenches the intrinsic noise of the repetition rate (and thus of the individual comb lines), which is now entirely determined by the frequency noise and spectral separation between the two pinned teeth. In the fully free-running lasers case, the two pinned teeth correspond to the main and reference pumps, as previously demonstrated^{28,34}, thereby yielding optical frequency division (OFD) by a factor μ_s^2 . However, this scheme is not unique, since other comb lines can be pinned through feedback to one of the pumps. In particular, the “first” tooth can be pinned through carrier-envelope offset (CEO) frequency (ω_{ceo}) stabilization, providing a larger $OFD = M_{\text{ref}}^2$, where $M_{\text{ref}} = \frac{\omega_{\text{ref}} - \omega_{\text{ceo}}}{\omega_{\text{rep}}}$ is the comb tooth order where KIS occurs and assuming ω_{ceo} is stabilized by feedback to the main pump (the reverse case could also be considered if ω_{CEO} is stabilized on the reference pump). To demonstrate this effect, we use the same microring resonator as in Fig. 2C, pumped at $\omega_p/2\pi = 285.467836 \text{ THz} \pm 3 \text{ MHz}$ ($\approx 1050.8 \text{ nm}$) and creating a DW at which we send the reference pump at $\omega_{\text{ref}}/2\pi = 192.559616 \text{ THz} \pm 2 \text{ MHz}$ ($\approx 1557.4 \text{ nm}$), with both frequencies obtained after measuring the repetition rate and CEO as we describe later. The uncertainty is a one standard deviation value that is dominated by the repetition rate uncertainty. Frequency doubling the reference pump using a periodically-poled lithium niobate waveguide enables $f - 2f$ interferometry against the short DW at $385.369148 \text{ THz} \pm 4 \text{ MHz}$ ($\approx 778.4 \text{ nm}$) for CEO detection [Fig. 4A]. The CEO can be efficiently detected with more than 60 dB dynamic range as a consequence of the reference pump laser being a comb tooth that provides large power for doubling and the increase in short DW power through the self-balancing effect in KIS^{28,50}. We use electro-optic modulation to detect $\omega_{\text{ceo}}/2\pi = -249.91559097 \text{ GHz} \pm 10 \text{ Hz}$ (from electrical spectrum analyzer recording bandwidth) and phase lock it to a 10 MHz Rubidium frequency standard, by actuating the main pump frequency through a proportional-integral-derivative (PID) controller [Fig. 4A]. In order to measure the repetition rate $\omega_{\text{rep}}/2\pi = 999.01312 \text{ GHz}$ ($\pm 10 \text{ kHz}$ from its linewidth under free running operation²⁸), we use a similar electro-optic apparatus that modulates two adjacent Kerr comb

teeth. This results in their spectral translation through higher-order modulation sidebands, creating a beat note between a sideband from each Kerr comb tooth that resides within a 50 MHz bandwidth and is detected by a low-noise avalanche photodiode. We proceed to measure S_{rep} for three difference cases: single pump [Fig. 4B(i)], KIS with free-running pumps [Fig. 4B(ii)], and KIS with a free-running reference and locked CEO [Fig. 4B(ii)]. In the first case, we observe the $1/f^2$ trend that is a signature of the TRN-limited behavior expected for a single-pumped cavity soliton, as presented above. It is worth pointing out that we use a cooler pump (counterpropagating and cross-polarized relative to the main pump) to thermally stabilize the cavity and provide adiabatic access to the DKS. While a low power cooler (in the 10 mW range) can suppress TRN in microring resonators by about an order of magnitude²¹, we do not observe such effects. In particular, the simulated S_{rep}^{1p} without cooler is orders-of-magnitude lower than our observed noise spectrum [Fig. 4B(vi)]. We note that for soliton access in our system, the cooler pump must be sufficiently strong, here between 150 mW to 300 mW of on-chip power^{51,52}, to counteract the thermal shift induced by the 150 mW power main pump and access the DKS state^{53,54}. Theoretically, it has been shown that thermal squeezing of integrated cavities works efficiently only at low cooler power, while actually deteriorating the TRN once a critical power threshold is passed²⁹. Therefore, the use of a pump cooler to generate a DKS, although convenient, can greatly degrade its noise metrics when not synchronized.

In the KIS regime, S_{rep}^{kis} does not follow the TRN profile, as expected from theory, as the frequency noise PSD at 2.5 kHz is brought down from $S_{\text{rep}}^{1p} \approx 4 \times 10^5 \text{ Hz}^2/\text{Hz}$ to $S_{\text{rep}}^{kis} \approx 10 \text{ Hz}^2/\text{Hz}$ in the completely free-running KIS case [Fig. 4B(ii)]. When comparing S_{rep}^{kis} and the expected TRN-limited PSD in the single pump case (without the cooler), one can observe that the KIS microcomb has already bypassed the otherwise intrinsic noise limitation of the cavity soliton, beating TRN for frequencies above 2 kHz and only limited by the free-running pump frequency noise. We also demonstrate that S_{rep}^{kis} is determined by the OFD factor of the KIS operation. In the above case of two free-running pumps, the measured repetition rate noise is well-reproduced by considering the combined pumps’ noise and $OFD = \mu_s^2 = 91^2$ [Fig. 4B(ii)]. When the CEO is locked through actuation of the main pump frequency, S_{rep}^{kis} is further reduced thanks to the larger $OFD = M_{\text{ref}}^2 = 193^2$ [Fig. 4B(v)], and is in good agreement with the measured pump frequency noise divided by this larger OFD factor. In this scenario, the reference remains free-running, while TRN is further beaten by a factor of 15 at low frequency. At high frequency, S_{rep}^{kis} is limited by the detection floor of the electro-optic apparatus used to measure the $\approx 1 \text{ THz}$ repetition rate of the KIS DKS [Fig. 4B(vii)].

Conclusion — In conclusion, we have demonstrated that Kerr-induced synchronization (KIS) enables, in an all-optical fashion, quenching of internal noise sources in integrated optical frequency combs, thereby making the comb noise metrics only dependent on the noise properties of the two pumps. Thanks to the phase-locking of the cavity soliton onto the reference laser, the comb exhibits a dual-pinning behavior which modifies the so-called elastic-tape model describing the noise propagation across comb teeth. This enables the effective linewidths of the comb teeth to remain within the same order of magnitude as the pump lasers, in contrast to the single pump soliton case where the comb tooth linewidth can be hundreds of times the pump linewidth at the edges of the comb spectrum. Despite the injection of another laser in the microring resonator, which could potentially raise its temperature and degrade the statistical fluctuations of the cavity refractive index, we demonstrate theoretically through a linear stability analysis of the Lugiato-Lefever equation that KIS quenches intra-cavity noise fluctuations, with an optimum at the center of the synchronization bandwidth (*i.e.*, where the comb tooth was previously located in a single pump regime). This is confirmed experimentally by measuring the repetition rate noise of the microcomb, which is found to be entirely determined by the pump laser noise metrics, and not by the thermo-refractive noise (TRN) of the cavity. The repetition rate noise is suppressed by more than four orders of magnitude while operating the

synchronized DKS with free-running pump lasers, and is about an order of magnitude lower than the minimum TRN that the singly-pumped soliton could exhibit in our system. We show that a pathway to improve the noise in KIS can be achieved by increasing the optical frequency division factor, which we demonstrate by self-stabilizing the microcomb through its CEO locking, reducing the repetition rate noise further by a factor 15 at low Fourier frequency.

Our work demonstrates that despite the low modal volume of integrated microcombs, which makes them predisposed to large TRN that can greatly hinder their performance, KIS can enable ultra-low-noise performance since the repetition rate noise becomes dependent only on the extrinsic noise properties of the pump lasers and the cavity photon lifetime. Optimization of the photon lifetime can be engineered by leveraging the coupling dispersion of pulley bus-ring couplers⁵⁵, further lowering the noise floor of the KIS microcomb. The external driving noise can be mitigated, since laser locking using on-chip reference cavities has been demonstrated to yield low-noise performance⁵⁶. Our work shows that KIS is a promising approach for the development of low-noise, self-stabilized integrated microcombs with low footprint for SWaP optimization and performance that can potentially become on-par performance with state-of-the-art fiber-based optical frequency combs.

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Acknowledgments — The photonic chips were fabricated in the same fashion as the ones presented in ref.²⁸, based on a thick Si₃N₄ process in a commercial foundry.⁵⁷ G.M and K.S acknowledge partial funding support from the AFRL Space Vehicles Directorate and the NIST-on-a-chip program. P.S and C.M. acknowledges support from the Air Force Office of Scientific Research (AFOSR grant FA9550-20-1-0357) and the National Science Foundation (NSF grant ECCS-18-07272). We thank Michael Highman for helping us with experimental instrumentation. We thank Roy Zektzer and Alioune Niang for insightful feedback. G.M dedicates this work to T.B.M – always.

Author Contributions — G.M designed the resonator, performed the experimental work, and led the project. P.S developed the theoretical understanding, the analytical framework, and performed the simulation. J.S provided help in the theoretical and experimental noise analysis and understanding. K.S and C.M provided guidance, feedback, and secured funding. G.M, P.S. and K.S. wrote the manuscript, with input from all authors. All the authors contributed and discussed the content of this manuscript.

Competing Interests — G.M., C.M. and K.S have submitted a provisional patent application based on aspects of the work presented in this paper.

Data availability — The data that supports the plots within this paper and other findings of this study are available from the corresponding authors upon request.

Supplementary Information: All-Optical Noise Quenching of An Integrated Frequency Comb

S.1 Derivation of analytical repetition rate noise

Temperature fluctuations in a microring resonator can be described by a Langevin equation,

$$\frac{d\Delta T}{dt} = -\Gamma_T \Delta T + \zeta_T, \quad (\text{S.1})$$

where Γ_T is the thermal dissipation rate and ζ_T is a white-noise fluctuation source defined by its autocorrelation,

$$\langle \zeta_T(t) \zeta_T(t + \tau) \rangle = \frac{\Gamma_T k_B T^2}{\rho C V} \delta(\tau). \quad (\text{S.2})$$

with the parameters as defined in the main text after Eq. 11. Taking the Fourier transform of Eq. (S.1), we get:

$$-if \Delta \tilde{T}(f) = -\Gamma_T \Delta \tilde{T}(f) + W(f). \quad (\text{S.3})$$

Therefore,

$$\Delta \tilde{T}(f) = \frac{W(f)}{\Gamma_T - if} \quad (\text{S.4})$$

$$S_{\tilde{T}}(f) = \frac{k_B T^2}{\rho C V} \frac{2\Gamma_T}{\Gamma_T^2 + f^2} \quad (\text{S.5})$$

For small fluctuations in temperature, the change in repetition rate can be written as:

$$\Delta \omega_{\text{rep}} = \eta_T \times \Delta T \quad (\text{S.6})$$

with $\eta_T = \left. \frac{\partial \omega_{\text{rep}}}{\partial T} \right|_{T_0}$ the variation of the repetition rate with temperature around T_0 , with more detail provided in Supplementary Information S.3. From Eq. (S.6), we can determine:

$$\Delta \tilde{\omega}_{\text{rep}}(f) = \eta_T \frac{W(f)}{\Gamma_T - if} \quad (\text{S.7})$$

Hence, when the DKS is under single pump operation (*i.e.* not synchronized to the reference), the power spectral density (PSD) of the frequency noise is given by:

$$S_{\omega_{\text{rep}}}(f) = \frac{\eta_T^2 k_B T^2}{\pi \rho C V} \frac{\Gamma_T}{\Gamma_T^2 + f^2} \quad (\text{S.8})$$

In the Kerr-induced synchronization (KIS) regime, from the linearization of the LLE presented in the main body of the manuscript, which yields the eigenvalues λ , one can define another Langevin equation that can be written assuming that fluctuations to the repetition rate damp exponentially,

$$\frac{\partial \Delta \omega_{\text{rep}}}{\partial t} = \lambda_{ps} \kappa \Delta \omega_{\text{rep}} + \eta_T \frac{d\Delta T}{dt} \quad (\text{S.9})$$

where $\kappa = 1/\tau_{\text{phot}}$ is the total loss rate accounting for the microresonator internal loss (from scattering and absorption) and the coupling loss, and is inversely proportion to the photon lifetime (τ_{phot}). Repeating the same operation as in Eq. (S.3):

$$\Delta \tilde{\omega}_{\text{rep}}(f) = \eta_T \frac{ifW(f)}{(\Gamma_T - if)(\lambda_{ps}\kappa - if)} \quad (\text{S.10})$$

yielding:

$$S_{\omega_{\text{rep}}}(f) = \frac{\eta_T^2 k_B T^2}{\pi \rho C V} \frac{\Gamma_T f^2}{(\Gamma_T^2 + f^2)(\lambda_{ps}^2 \kappa^2 + f^2)} \quad (\text{S.11})$$

First, it is interesting to note that to minimize $S_{\omega_{\text{rep}}}(f)$, one needs to minimize λ_{ps} , which corresponds well with the LLE simulation occurring at the center of the KIS bandwidth, where $\lambda_{ps} = -1$. Secondly, outside of synchronization we obtained $\lambda_{ps} = 0$, which correctly makes Eq. (S.10) equal Eq. (S.8).

The physical quantities used in simulations, which match the ring resonator design that yields the microcombs in Figs. 2 and 4 are summarized in Table S.II.

S.2 Multi-driven Lugiato-Lefever equation details

Here we detail the normalization used to arrive at the Lugiato-Lefever equation (LLE) in Eq. (3). We assume that one can readily arrive at the LLE from the nonlinear Schrödinger equation with periodic boundary condition at every round trip⁵⁸, leading to:

$$\frac{\partial a(\theta, t)}{\partial t} = -\left(\frac{\kappa}{2} + i\delta\omega_p\right) a - i\gamma L |a|^2 a + i\frac{D_2}{2} \frac{\partial^2}{\partial \theta^2} a + \sqrt{\kappa_{\text{ext}} P_p} \quad (\text{S.1})$$

with a the intracavity field, θ the azimuthal coordinate of the resonator moving at the speed of the DKS such that $\theta \mapsto \theta - \omega_{\text{rep}} t$, $\delta\omega_p$ the pump detuning relative to the cold resonance frequency, $\kappa = 2\kappa_{\text{ext}}$ the total loss, which in the critical coupling case equals twice the external (coupling) losses, $\gamma = 3.1 \text{ W}^{-1} \cdot \text{m}^{-1}$ the effective nonlinear coefficient of the system at the 285.5 THz pump frequency (calculated through the finite-element method (FEM)), $L = 2\pi R = 144.51 \text{ }\mu\text{m}$ the perimeter of the resonator, and D_2 the group velocity dispersion of the system.

One could extend the previous equation in the case of higher-order dispersion coefficients such that $D_{\text{int}}(\mu) = \sum_{k>1} \frac{D_k}{k!} \mu^k$, with μ the azimuthal mode relative to the pump, while noticing that $\sum_{k>1} (-i)^{k+1} \frac{D_k}{k!} \frac{\partial^k}{\partial \theta^k} a = \sum_{\mu} D_{\text{int}}(\mu) A(\mu, t) \exp(i\mu\theta)$, where $A(\mu) = \text{FT}[a(\theta, t)]$ is the Fourier transform of the intracavity field from θ to μ .

In addition, a secondary pump can be introduced into the system following ref 43 and leading to:

$$\begin{aligned} \frac{\partial a(\theta, t)}{\partial t} = & -\left(\frac{\kappa}{2} + i\delta\omega_p\right) a - i\gamma L |a|^2 a + \sum_{\mu} D_{\text{int}}(\mu) A(\mu, t) e^{i\mu\theta} \\ & + \sqrt{\kappa_{\text{ext}} P_p} + \sqrt{\kappa_{\text{ext}} P_{\text{ref}}} \exp\left[i(\delta\omega_{\text{ref}} - \delta\omega_p + D_{\text{int}}(\mu_s))t - i\mu_s\theta\right] \end{aligned} \quad (\text{S.2})$$

with $\delta\omega_{\text{ref}}$ the detuning of the reference relative to its cold cavity, which is offset from the fixed frequency grid spaced by ω_{rep} by $D_{\text{int}}(\mu_s)$, with μ_s the mode at which the reference is injected in the cavity and where the synchronization will happen, and P_{ref} the reference power in the waveguide.

Using the change of variable $t \mapsto \frac{\kappa}{2} t$ we obtain Eq. (3) assuming the following normalization in Table S.I:

Table S.I: Normalized parameters in Eq. (3)

Parameter	Normalization
ψ	$\sqrt{\frac{2\gamma L}{\kappa}} a^*$
α_p	$-\frac{2}{\kappa} \delta\omega_p$
α_{ref}	$-\frac{2}{\kappa} \delta\omega_{\text{ref}}$
$\mathcal{D}(\mu)$	$-\frac{2D_{\text{int}}(\mu)}{\kappa}$
F_p	$\sqrt{\frac{2\kappa_{\text{ext}}\gamma L}{\kappa}} P_p$
F_{ref}	$\sqrt{\frac{2\kappa_{\text{ext}}\gamma L}{\kappa}} P_{\text{ref}}$

S.3 Details on the simulation of the thermo-refractive noise

Here, we describe the simulation details used to calculate the repetition-rate noise due to TRN using the LLE. The intracavity temperature is modeled as a stochastic variable with a white Gaussian driving force and subject to fluctuation dissipation. This yields the Langevin equation:

$$\frac{dT}{dt} = -\Gamma_T \Delta T + \zeta_T, \quad (\text{S.1})$$

where Γ_T is the thermal dissipation rate, and the temperature driving term ζ_T is defined by the autocorrelation function,

$$\langle \zeta_T(t) \zeta_T(t + \tau) \rangle = \frac{2\Gamma_T k_B T^2}{\rho C V}. \quad (\text{S.2})$$

Fluctuations in the intracavity temperature lead to fluctuations in the pump detunings,

$$\alpha_p(T) = \frac{-2}{\kappa}(\omega_{\mu_0}(T) - \omega_p), \quad (\text{S.3})$$

$$\alpha_s(T) = \frac{-2}{\kappa}(\omega_{\mu_s}(T) - \omega_s), \quad (\text{S.4})$$

and in the dispersion relation,

$$\omega_\mu(T) = \omega_\mu(T_0) - (T - T_0) \times \eta_\nu \frac{\omega_\mu^2(T_0)L_{\text{RT}}}{(\mu + m)c}, \quad (\text{S.5})$$

where η_ν is the material thermo-optic coefficient, L_{RT} is the cavity round-trip length, m is the mode number of the pumped mode, and c is the speed of light in vacuum. The temperature dependent detunings and dispersion relation can be combined into the following expression for the effective integrated dispersion at temperature T ,

$$\mathcal{D}(\mu, T) = \frac{-2}{\kappa}(\omega_\mu(T) - \omega_{\mu_0}(T_0) - \mu D_1), \quad (\text{S.6})$$

where $D_1/2\pi$ is the microresonator free spectral range. This leads to the temperature dependent LLE being written as,

$$\begin{aligned} \frac{\partial \psi}{\partial t} = & -(1 + i\alpha_p(T_0))\psi + i \sum_{\mu} \mathcal{D}(\mu, T) \tilde{\Psi} e^{i\mu\theta} + i|\psi|^2\psi \\ & + F_p + F_r \exp\left[i\left(\alpha_{\text{ref}}(T_0) - \alpha_p(T_0) + \mathcal{D}(\mu_s, T_0)\right)t - i\mu_s\theta\right] \end{aligned} \quad (\text{S.7})$$

The change in repetition rate $\Delta\omega_{\text{rep}}$ due to change in temperature can be calculated directly from the temperature-dependent LLE by tracking the change in the soliton position over time

$$\Delta\omega_{\text{rep}}[i] = \frac{\theta_{\text{max}}[i] - \theta_{\text{max}}[i-1]}{\Delta t \times R}, \quad (\text{S.8})$$

where $[i]$ denotes the i^{th} time step. Monte-Carlo simulations were performed to calculate the PSD. The $\Delta\omega_{\text{rep}}$ data was recorded with a sampling frequency of 10^7 Hz and a frequency resolution of 62.3 Hz. The PSD was calculated by taking the discrete Fourier transform as $|\Delta\tilde{\omega}_{\text{rep}}(f)|^2$. To obtain a good estimate, 144 parallel simulations were performed at the UMBC HPCF and an averaged PSD was obtained. The quantity η_T that is used in Supplementary Information S.1 was found by calculating the change in repetition rate locally around the mean temperature T_0 using the temperature-dependent LLE as,

$$\eta_T = \left. \frac{\partial \omega_{\text{rep}}}{\partial T} \right|_{T_0} = \frac{\omega_{\text{rep}}(T_0 + \delta T) - \omega_{\text{rep}}(T_0 - \delta T)}{2\delta T}, \quad (\text{S.9})$$

for a small δT . The parameters used for the TRN simulation are summarized in Table S.II

S.4 Summary of physical parameters

The physical parameters used in this study to investigate the noise of the microcomb under KIS can be summarized in Table S.II below:

is detected with another APD. The signal is then locked using a PID controller to feed back onto the main pump frequency and lock the CEO-translated beat to a 10 MHz Rubidium frequency standard.

S.6 Comb linewidth measurement

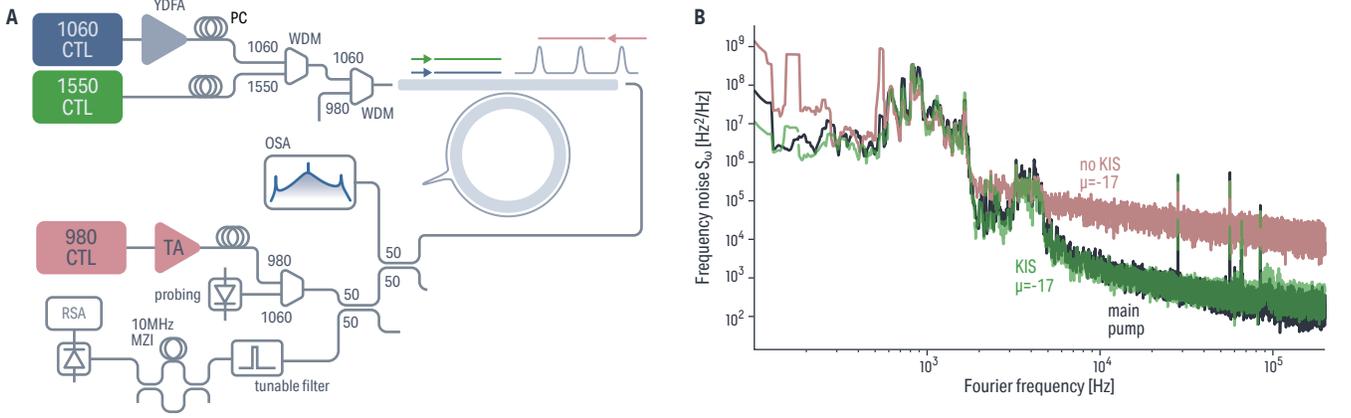


Fig. S.2 – (A) Experimental setup for the comb generation and linewidth analysis of individual comb teeth. CTL: continuously tunable laser, YDFA: Ytterbium doped fiber amplifier, EDFA: erbium doped fiber amplifier, WDM: wavelength demultiplexer, PC: polarization controller, TA: tapered amplifier, OSA: optical spectrum analyzer, RSA: real time spectrum analyser. (B) Frequency noise power spectral density of the main pump (black) and the comb line at $\mu = -17$ out of synchronizaion (red) and in KIS (green), exhibiting a clear change of the noise profile, from which the effective linewidth is extracted.

The comb linewidth measurement setup is depicted in Fig. S.2A. The main, reference, and cooler pumps are prepared in the same fashion as in Fig. S.1. On the output side, however, we use a Gaussian-shape band-pass fiber Bragg grating filter with 0.1 nm full-width half-maximum bandwidth and tunable center wavelength from 980 nm to 1140 nm, which enables us to filter out only one comb line of interest and send it to the 10 MHz unbalanced MZI optical frequency discriminator providing, after processing, the frequency noise of the μ^{th} tooth [Fig. S.2B]. From the frequency noise PSD $S_{\omega}(f)$, we extract the effective linewidth Δf_{eff} such that:

$$\int_{\Delta f_{\text{eff}}}^{+\infty} \frac{S_{\omega}(f)}{f^2} df = \frac{1}{\pi} \quad (\text{S.1})$$